

MiniSKiiP® 3 PIM
600V/100A
Features

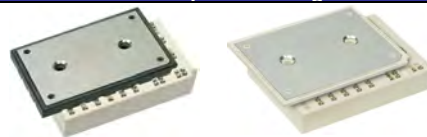
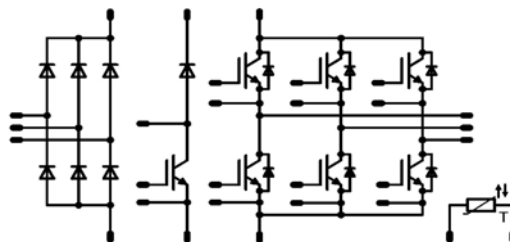
- IGBT3 technology for low saturation losses
- Solderless spring contact mounting system

Target Applications

- Industrial motor drives

Types

- V23990-K243-A-PM

MiniSKiiP® 3 housing

Schematic


Maximum Ratings

 $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
D8,D9,D10,D11,D12,D13				
Repetitive peak reverse voltage	V_{RRM}		1600	V
DC forward current	I_{FAV}	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$ $T_c = 80^\circ\text{C}$	69 93	A
Surge forward current	I_{FSM}	$t_p = 10\text{ms}$ $T_j = 25^\circ\text{C}$	700	A
I^2t -value	I^2t		2450	A^2s
Power dissipation per Diode	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$ $T_c = 80^\circ\text{C}$	77 117	W
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$

T1,T2,T3,T4,T5,T6,T7

Collector-emitter break down voltage	V_{CE}		600	V
DC collector current	I_C	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$ $T_c = 80^\circ\text{C}$	85 85	A
Repetitive peak collector current	I_{Cpulse}	t_p limited by T_{jmax}	300	A
Turn off safe operating area		$V_{CE} \leq 1200\text{V}$, $T_j \leq T_{op max}$	300	A
Power dissipation per IGBT	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ\text{C}$ $T_c = 80^\circ\text{C}$	154 224	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq 150^\circ\text{C}$ $V_{GE} = 15\text{V}$	6 360	μs V
Maximum Junction Temperature	T_{jmax}		175	$^\circ\text{C}$

Maximum Ratings

$T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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D1,D2,D3,D4,D5,D6,D7

Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	75 75	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	985	A
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	119 181	W
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}\text{C}$

Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	T_{op}		-40...+125	$^{\circ}\text{C}$

Insulation Properties

Insulation voltage	V_{is}	$t=2s$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			$V_{GE}[V]$ or $V_{GS}[V]$	$V_r[V]$ or $V_{CE}[V]$ or $V_{DS}[V]$	$I_C[A]$ or $I_F[A]$ or $I_D[A]$	T_j	Min	Typ	Max	
D8,D9,D10,D11,D12,D13										
Forward voltage	V_F				35	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	0,8	1,02 0,94	1,35	V
Threshold voltage (for power loss calc. only)	V_{th}				35	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		0,88 0,75		V
Slope resistance (for power loss calc. only)	r_t				35	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		4 6		mΩ
Reverse current	I_r			1500		$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			0,1 2	mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1$ W/mK						0,90		K/W

T1,T2,T3,T4,T5,T6,T7										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,008	$T_j=25^{\circ}C$ $T_j=150^{\circ}C$	5	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		100	$T_j=25^{\circ}C$ $T_j=150^{\circ}C$	1,05	1,58 1,78	1,85	V
Collector-emitter cut-off current incl. Diode	I_{CES}		0	600		$T_j=25^{\circ}C$ $T_j=150^{\circ}C$			0,0052	mA
Gate-emitter leakage current	I_{GES}		±25	0		$T_j=25^{\circ}C$ $T_j=150^{\circ}C$			1200	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(on)}$	Rgoff=8 Ω Rgon=8 Ω	±15	300	100	$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		187,2 187,2		ns
Rise time	t_r					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		31,5 32,8		
Turn-off delay time	$t_{d(off)}$					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		222,5 241,8		
Fall time	t_f					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		53,3 86,9		
Turn-on energy loss per pulse	E_{on}					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		2,29 2,92		mWs
Turn-off energy loss per pulse	E_{off}					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		2,43 3,08		
Input capacitance	C_{ies}	f=1MHz	0	25		$T_j=25^{\circ}C$		6280		pF
Output capacitance	C_{oss}							400		
Reverse transfer capacitance	C_{rss}							186		
Gate charge	Q_{Gate}		±15	480	100	$T_j=25^{\circ}C$		620		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1$ W/mK						0,6		K/W

D1,D2,D3,D4,D5,D6,D7										
Diode forward voltage	V_F				100	$T_j=25^{\circ}C$ $T_j=150^{\circ}C$	1	1,38 1,4	1,9	V
Peak reverse recovery current	I_{RRM}	Rgoff=8 Ω		300	100	$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		92,8 112,9		A
Reverse recovery time	t_{rr}					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		167,5 247,7		ns
Reverse recovered charge	Q_{rr}					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		5,85 10,5		μC
Peak rate of fall of recovery current	$di(rec)_{max}/dt$					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		3184 2578		A/μs
Reverse recovered energy	E_{rec}					$T_j=25^{\circ}C$ $T_j=150^{\circ}C$		1,1 2,15		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1$ W/mK						0,8		K/W

Thermistor										
Rated resistance	R					T=25°C		1000		Ω
Deviation of R100	$\Delta R/R$	R100=1670 Ω				T=100°C	-3		3	%
R100	P					T=100°C		1670,313		Ω
Power dissipation constant						T=25°C				mW/K
A-value	B(25/50)	Tol. %				T=25°C		7,635*10-3		1/K
B-value	B(25/100)	Tol. %				T=25°C		1,731*10-5		1/K²
Vincotech NTC Reference									E	

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 1 T1,T2,T3,T4,T5,T6,T7 IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

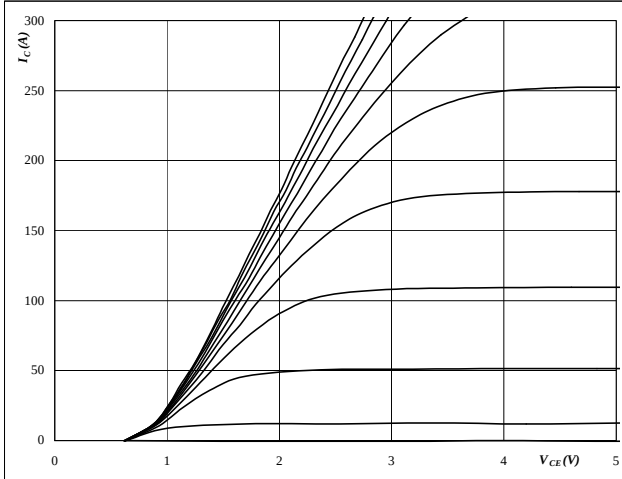

At
 $t_p = 250 \mu s$
 $T_J = 25^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 T1,T2,T3,T4,T5,T6,T7 IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

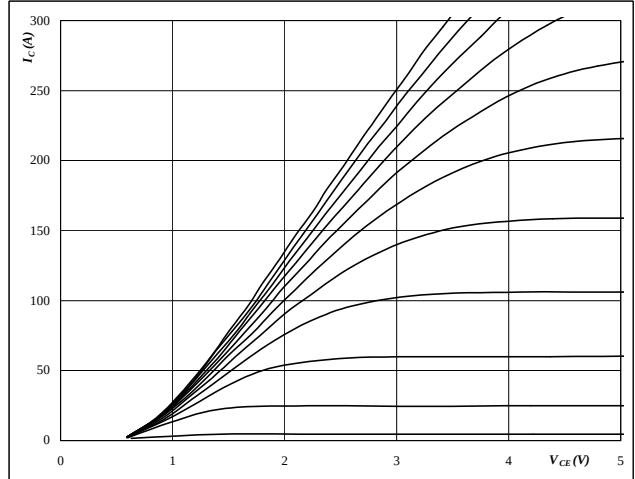
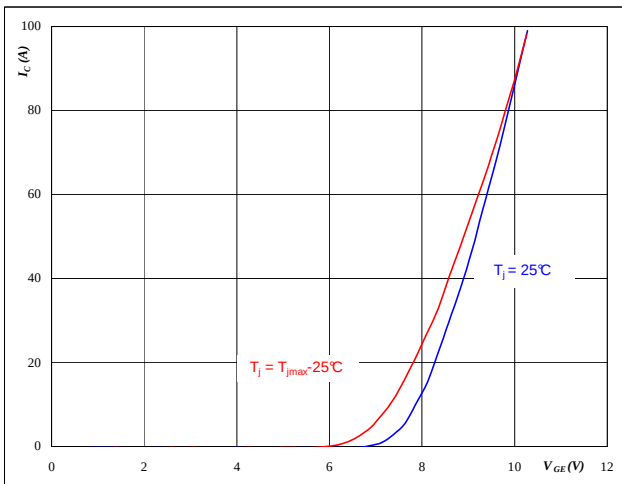

At
 $t_p = 250 \mu s$
 $T_J = 125^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 T1,T2,T3,T4,T5,T6,T7 IGBT

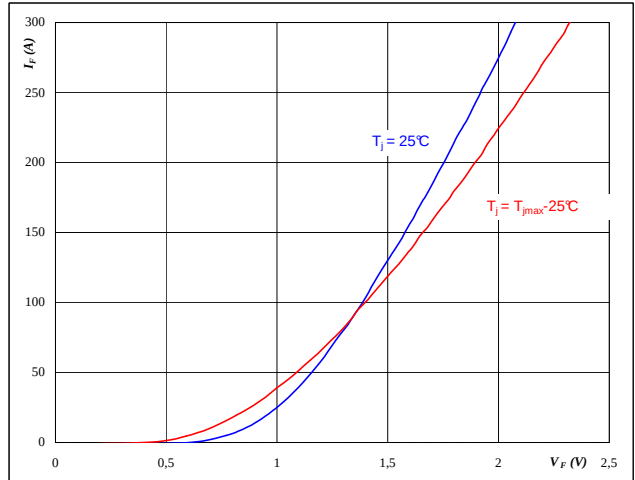
Typical transfer characteristics

$$I_C = f(V_{GE})$$


At
 $t_p = 250 \mu s$
 $V_{CE} = 10 V$
Figure 4 D1,D2,D3,D4,D5,D6,D7 FWD

Typical diode forward current as a function of forward voltage

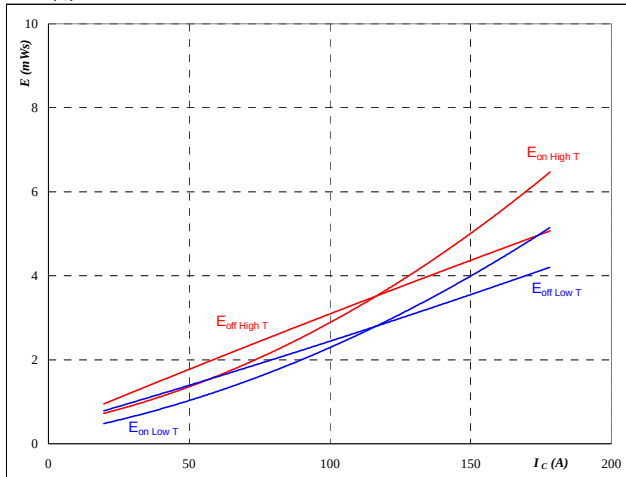
$$I_F = f(V_F)$$


At
 $t_p = 250 \mu s$

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 5 T1,T2,T3,T4,T5,T6,T7 IGBT

**Typical switching energy losses
as a function of collector current**

$$E = f(I_C)$$



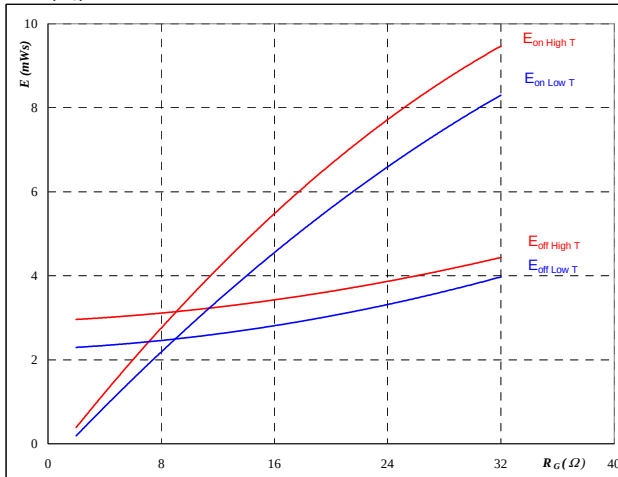
With an inductive load at

$T_J = 25/125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω
 $R_{goff} = 8$ Ω

Figure 6 T1,T2,T3,T4,T5,T6,T7 IGBT

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



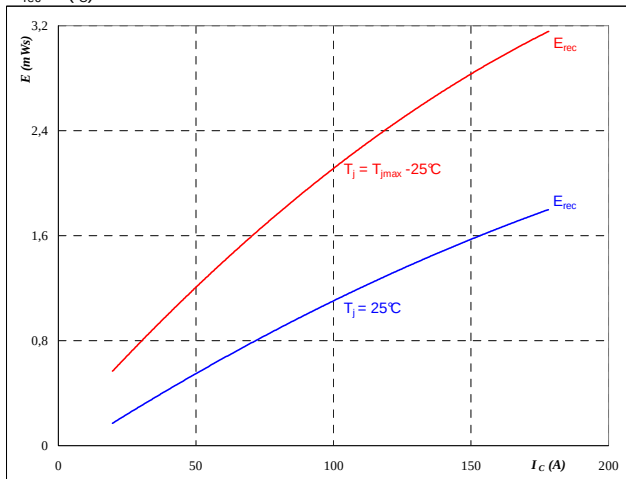
With an inductive load at

$T_J = 25/125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $I_C = 100$ A

Figure 7 T1,T2,T3,T4,T5,T6,T7 IGBT

**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_C)$$



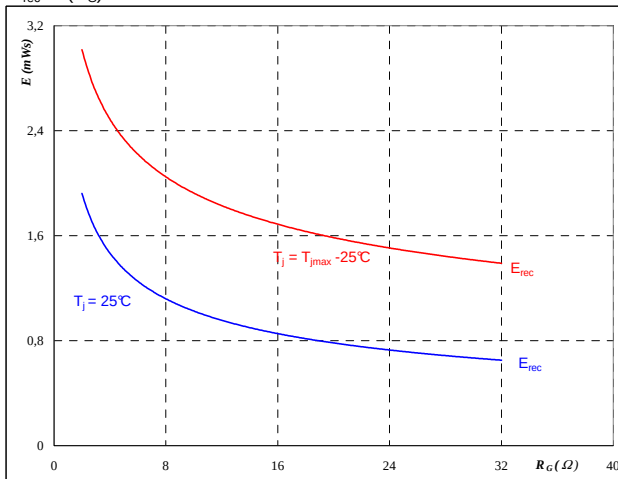
With an inductive load at

$T_J = 25/125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω

Figure 8 T1,T2,T3,T4,T5,T6,T7 IGBT

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



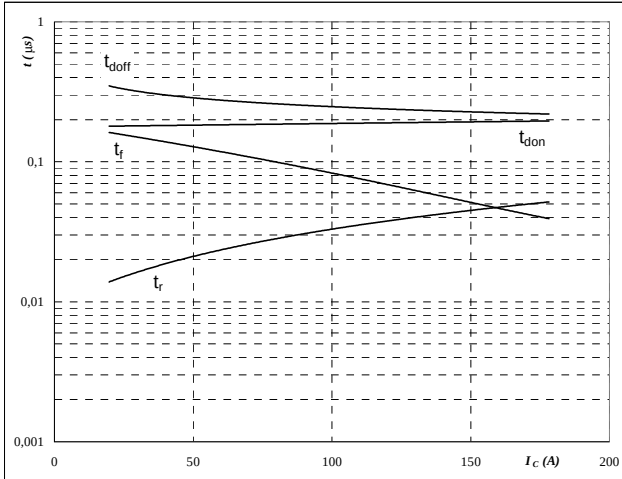
With an inductive load at

$T_J = 25/125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $I_C = 100$ A

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 9 T1,T2,T3,T4,T5,T6,T7 IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



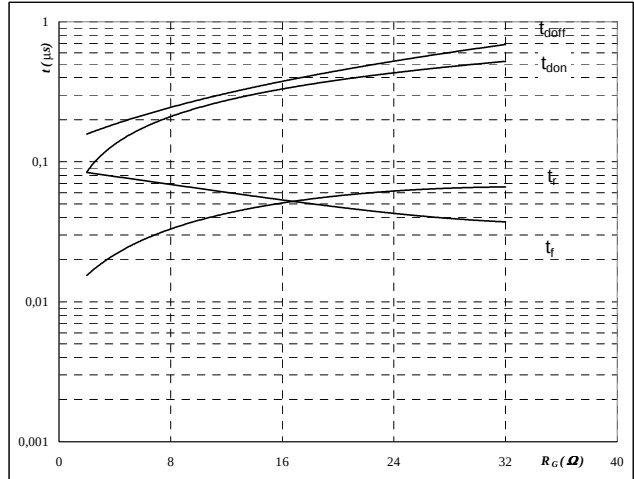
With an inductive load at

$T_J = 125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω
 $R_{goff} = 8$ Ω

Figure 10 T1,T2,T3,T4,T5,T6,T7 IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



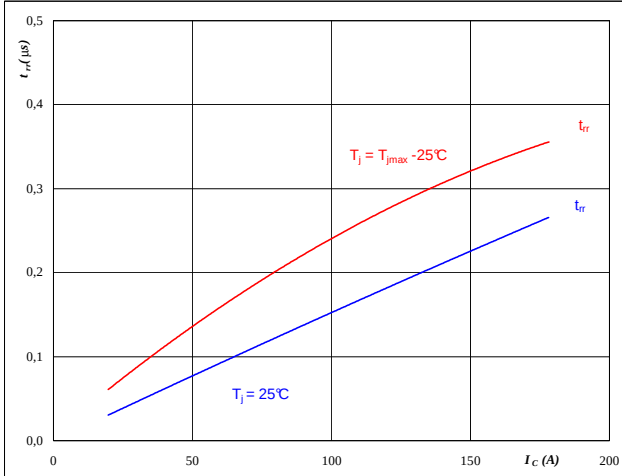
With an inductive load at

$T_J = 125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $I_C = 100$ A

Figure 11 D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



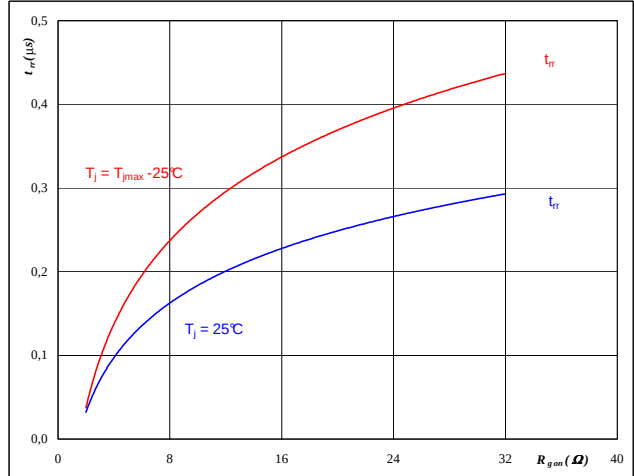
At

$T_J = 25/125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω

Figure 12 D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



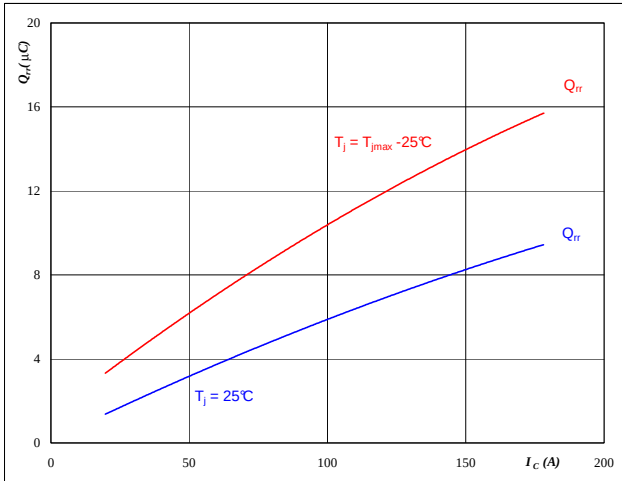
At

$T_J = 25/125$ °C
 $V_R = 300$ V
 $I_F = 100$ A
 $V_{GE} = \pm 15$ V

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 13 D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$



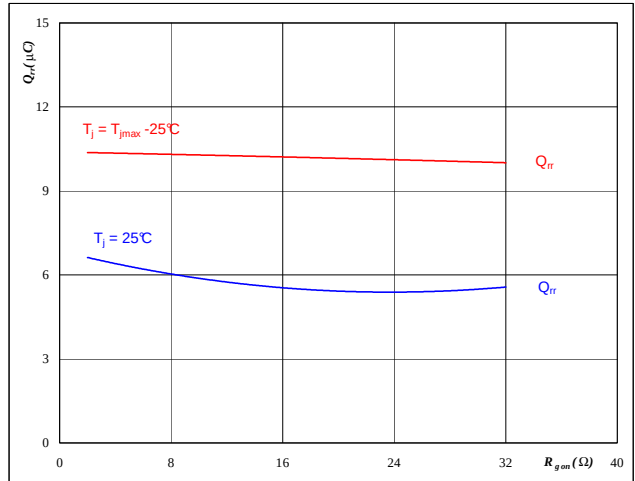
At

$T_j =$	25/125	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω

Figure 14 D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$



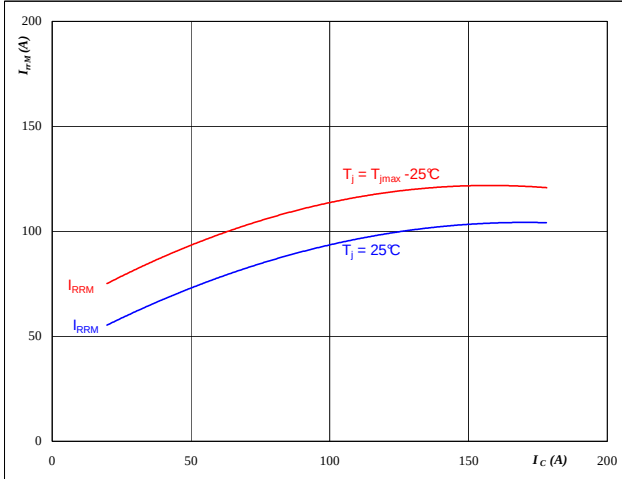
At

$T_j =$	25/125	°C
$V_R =$	300	V
$I_F =$	100	A
$V_{GE} =$	±15	V

Figure 15 D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$



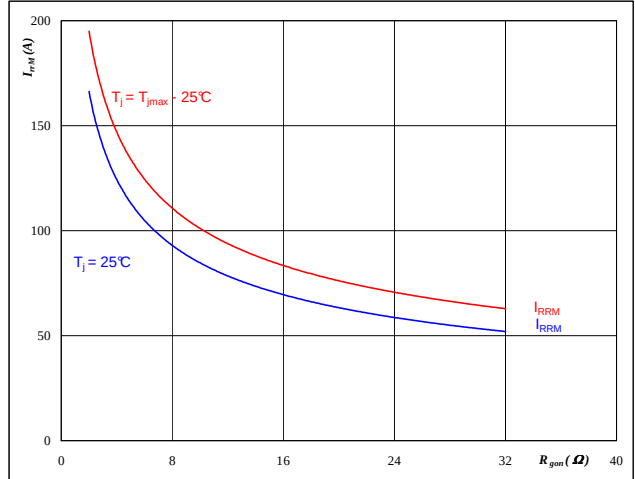
At

$T_j =$	25/125	°C
$V_{CE} =$	300	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω

Figure 16 D1,D2,D3,D4,D5,D6,D7 FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



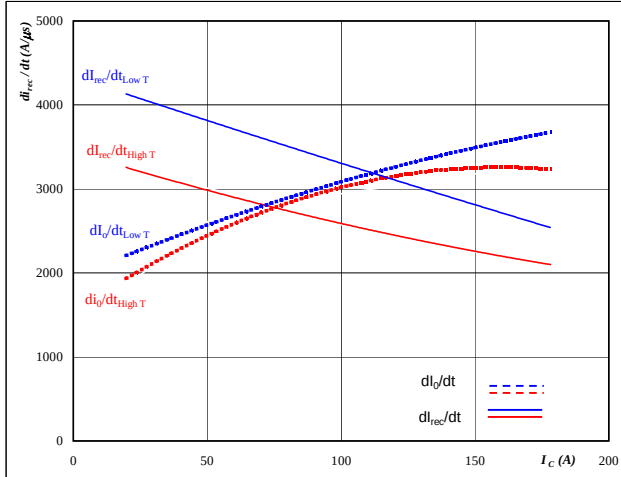
At

$T_j =$	25/125	°C
$V_R =$	300	V
$I_F =$	100	A
$V_{GE} =$	±15	V

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 17 D1,D2,D3,D4,D5,D6,D7 FWD

Typical rate of fall of forward
and reverse recovery current as a
function of collector current

$$dI_F/dt, dI_{rec}/dt = f(I_C)$$



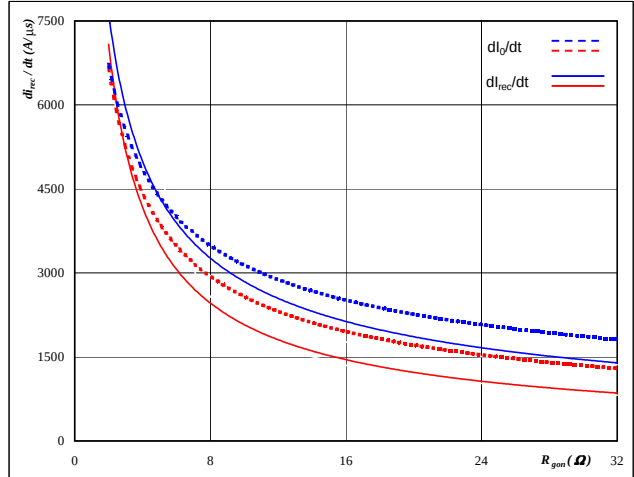
At

$T_J = 25/125$ °C
 $V_{CE} = 300$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω

Figure 18 D1,D2,D3,D4,D5,D6,D7 FWD

Typical rate of fall of forward
and reverse recovery current as a
function of IGBT turn on gate resistor

$$dI_F/dt, dI_{rec}/dt = f(R_{gon})$$



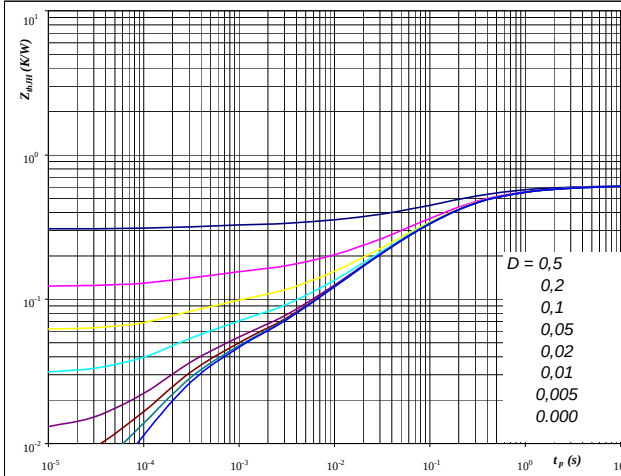
At

$T_J = 25/125$ °C
 $V_R = 300$ V
 $I_F = 100$ A
 $V_{GE} = \pm 15$ V

Figure 19 T1,T2,T3,T4,T5,T6,T7 IGBT

IGBT transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At

$D = t_p / T$
 $R_{thJH} = 0,62$ K/W

IGBT thermal model values

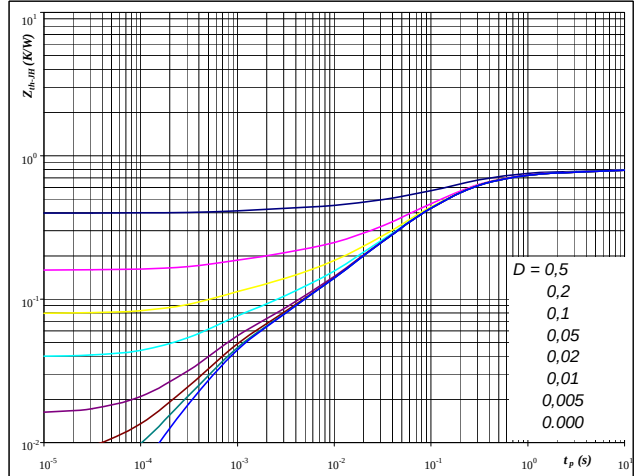
Thermal grease

R (C/W)	Tau (s)
0,04	6,5E+00
0,09	1,0E+00
0,23	2,0E-01
0,15	5,9E-02
0,07	1,2E-02
0,02	2,2E-03

Figure 20 D1,D2,D3,D4,D5,D6,D7 FWD

FWD transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At

$D = t_p / T$
 $R_{thJH} = 0,80$ K/W

FWD thermal model values

Thermal grease

R (C/W)	Tau (s)
0,08	2,9E+00
0,26	3,2E-01
0,33	8,4E-02
0,08	1,1E-02
0,05	7,9E-04

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 21 T1,T2,T3,T4,T5,T6,T7 IGBT

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

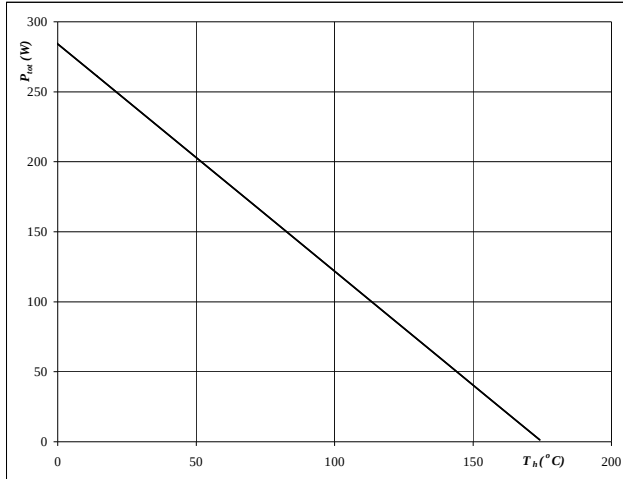

At
 $T_j = 175$ °C

Figure 22 T1,T2,T3,T4,T5,T6,T7 IGBT

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$

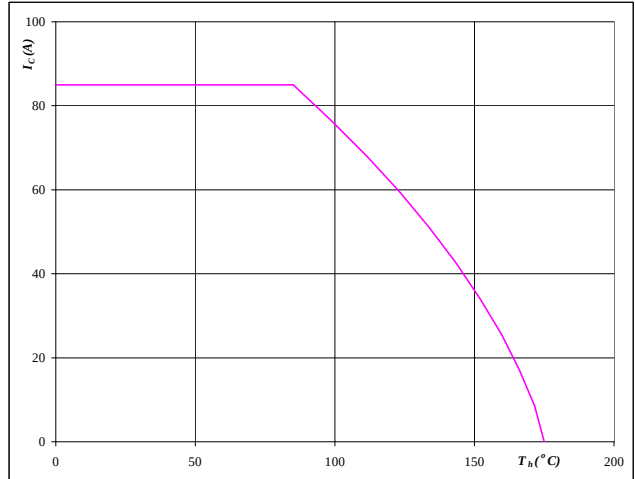

At
 $T_j = 175$ °C
 $V_{GE} = 15$ V

Figure 23 D1,D2,D3,D4,D5,D6,D7 FWD

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

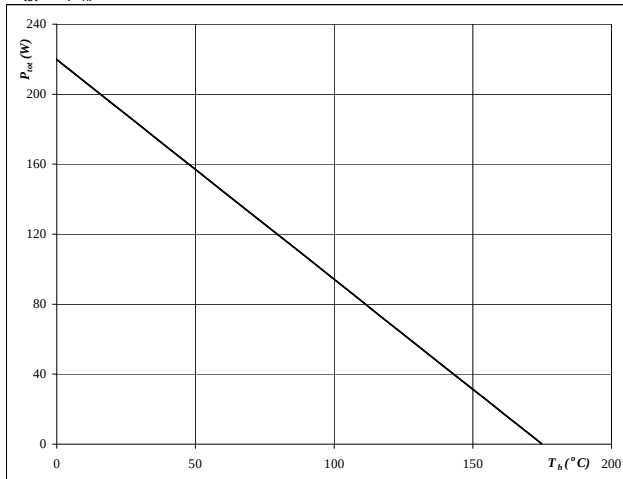
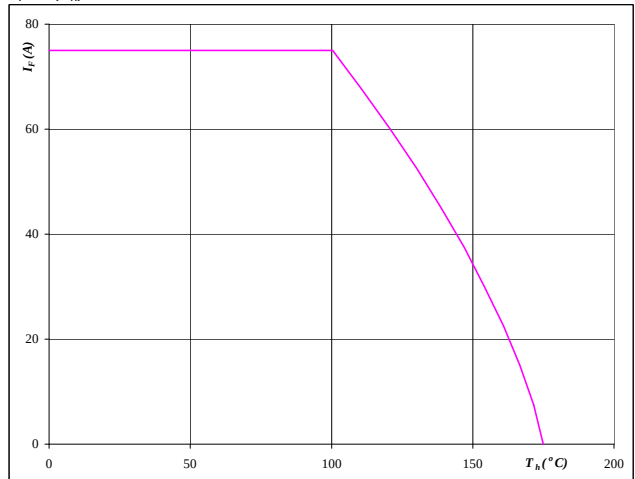

At
 $T_j = 175$ °C

Figure 24 D1,D2,D3,D4,D5,D6,D7 FWD

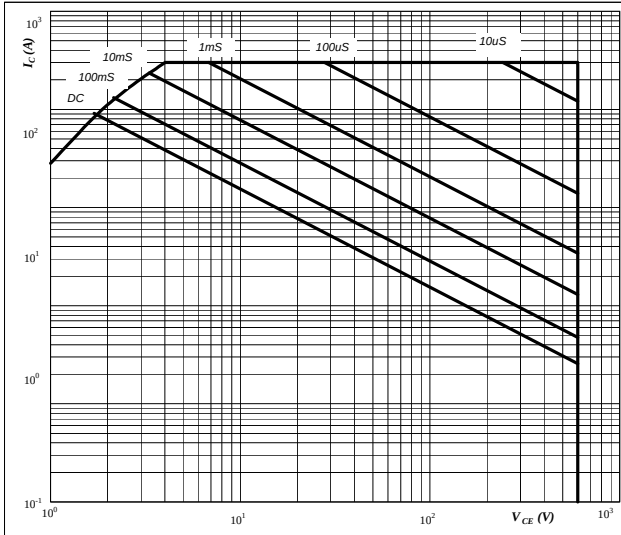
Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$


At
 $T_j = 175$ °C

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 25

T1,T2,T3,T4,T5,T6,T7 IGBT

**Safe operating area as a function
of collector-emitter voltage**
 $I_C = f(V_{CE})$

At

D = single pulse

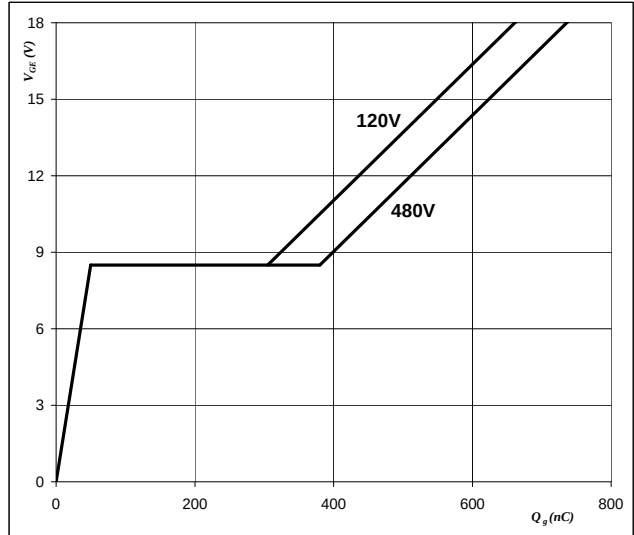
 $T_h = 80$ °C

 $V_{GE} = \pm 15$ V

 $T_j = T_{jmax}$ °C

Figure 26

T1,T2,T3,T4,T5,T6,T7 IGBT

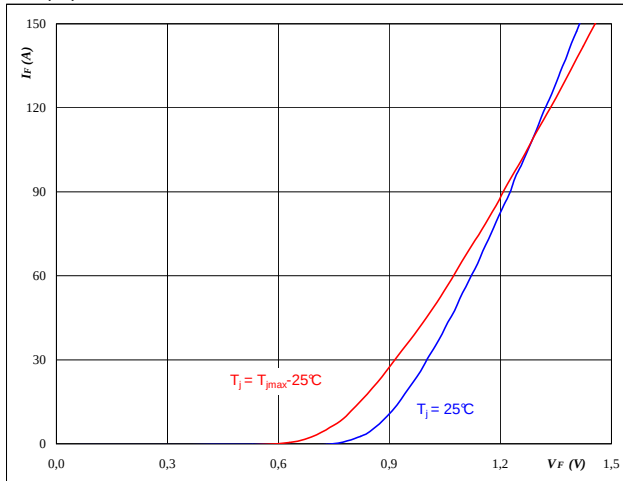
Gate voltage vs Gate charge
 $V_{GE} = f(Q_{GE})$

At
 $I_C = 100$ A

D8,D9,D10,D11,D12,D13

Figure 1 D8,D9,D10,D11,D12,D13 diode

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$

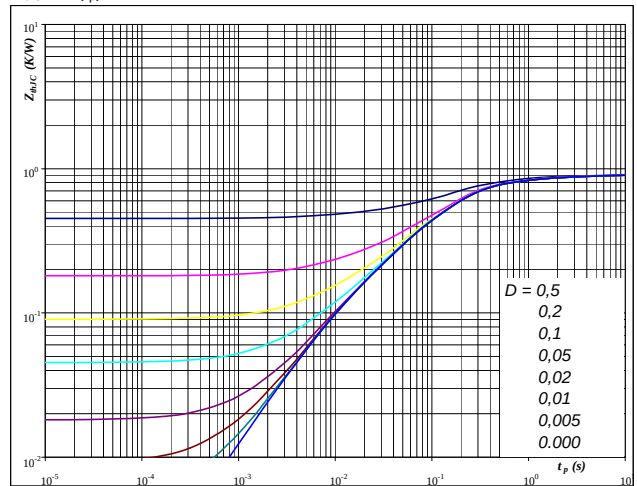


At
 $t_p = 250 \mu s$

Figure 2 D8,D9,D10,D11,D12,D13 diode

Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$

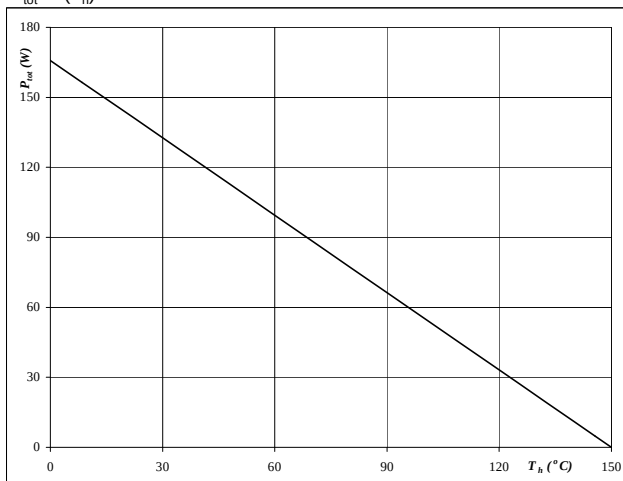


At
 $D = t_p / T$
 $R_{thJH} = 0,90 \text{ K/W}$

Figure 3 D8,D9,D10,D11,D12,D13 diode

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

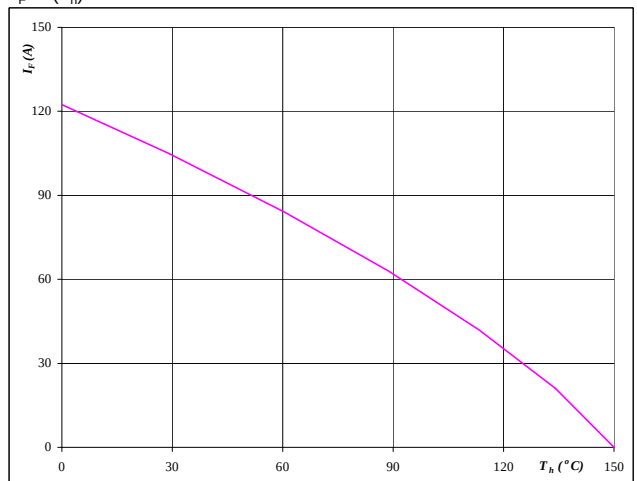


At
 $T_j = 150 \text{ °C}$

Figure 4 D8,D9,D10,D11,D12,D13 diode

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$



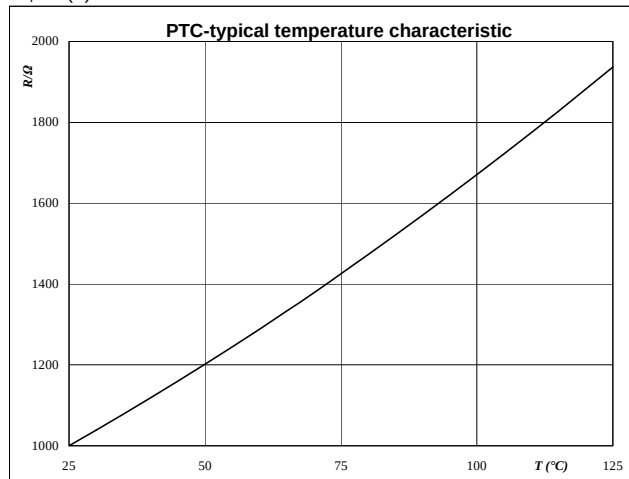
At
 $T_j = 150 \text{ °C}$

Thermistor

Figure 1 Thermistor

**Typical PTC characteristic
as a function of temperature**

$$R_T = f(T)$$



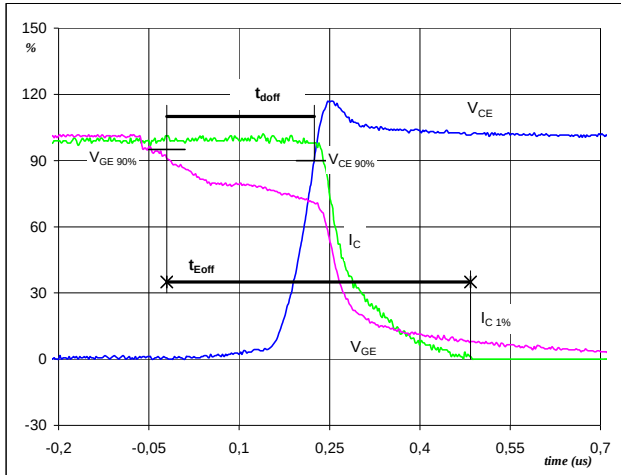
Switching Definitions Output Inverter

General conditions

T_j	=	125 °C
R_{gon}	=	8 Ω
R_{goff}	=	8 Ω

Figure 1 Output inverter IGBT

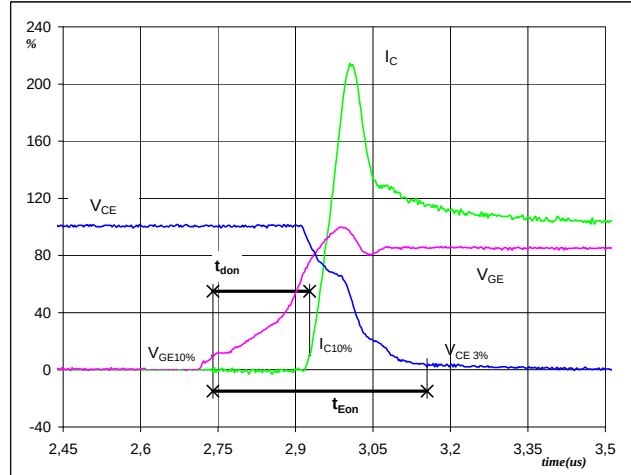
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$	=	-15	V
$V_{GE}(100\%)$	=	15	V
$V_C(100\%)$	=	300	V
$I_C(100\%)$	=	99	A
t_{doff}	=	0,24	μs
t_{Eoff}	=	0,50	μs

Figure 2 Output inverter IGBT

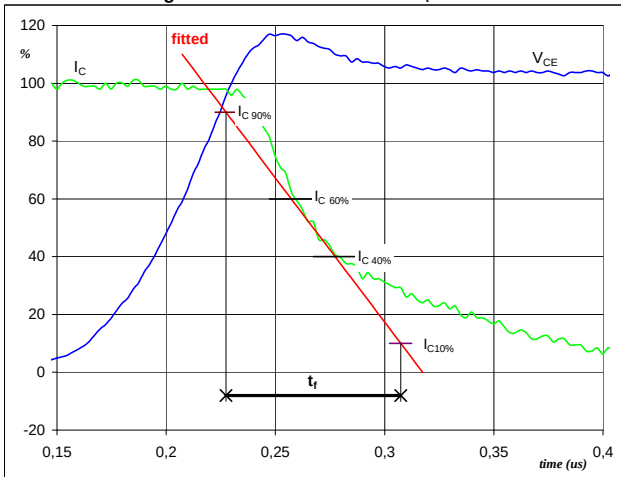
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$	=	-15	V
$V_{GE}(100\%)$	=	15	V
$V_C(100\%)$	=	300	V
$I_C(100\%)$	=	99	A
t_{don}	=	0,19	μs
t_{Eon}	=	0,41	μs

Figure 3 Output inverter IGBT

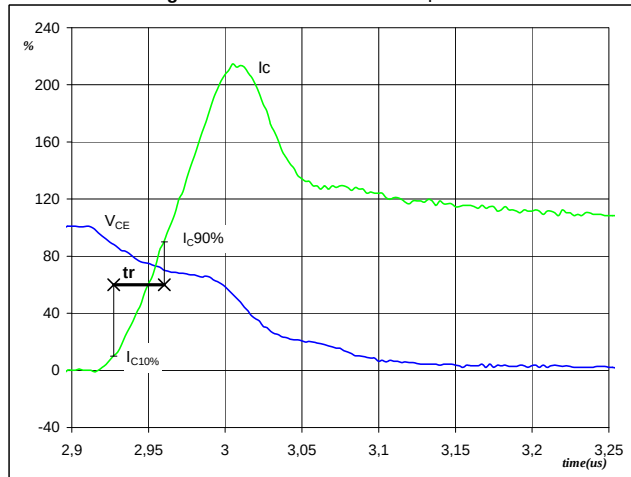
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$	=	300	V
$I_C(100\%)$	=	99	A
t_f	=	0,09	μs

Figure 4 Output inverter IGBT

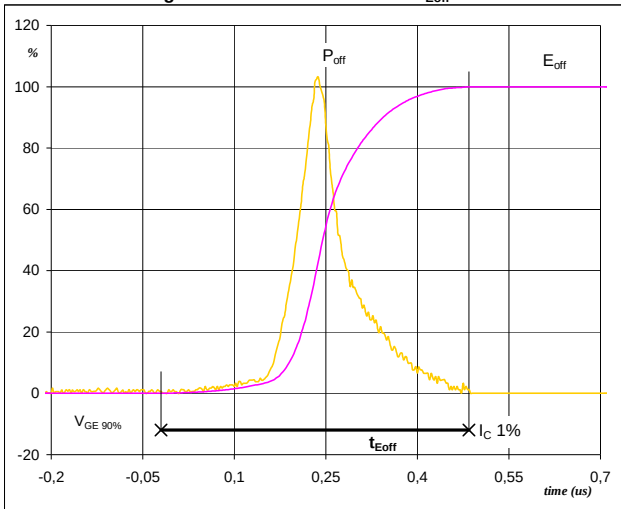
Turn-on Switching Waveforms & definition of t_r



$V_C(100\%)$	=	300	V
$I_C(100\%)$	=	99	A
t_r	=	0,03	μs

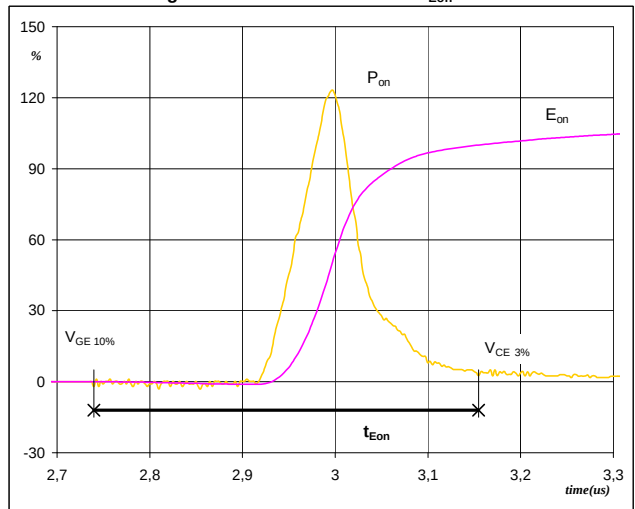
Switching Definitions Output Inverter

Figure 5 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{Eoff}


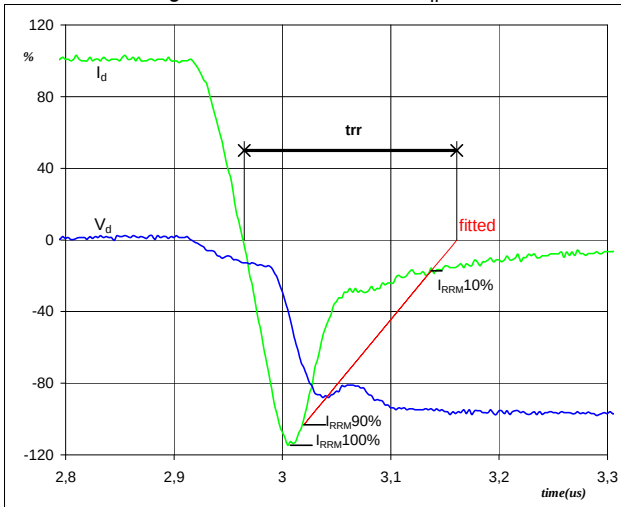
$P_{off}(100\%) = 29,72 \text{ kW}$
 $E_{off}(100\%) = 3,08 \text{ mJ}$
 $t_{Eoff} = 0,50 \text{ }\mu\text{s}$

Figure 6 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_{Eon}


$P_{on}(100\%) = 29,72 \text{ kW}$
 $E_{on}(100\%) = 2,92 \text{ mJ}$
 $t_{Eon} = 0,41 \text{ }\mu\text{s}$

Figure 7 Output inverter FWD

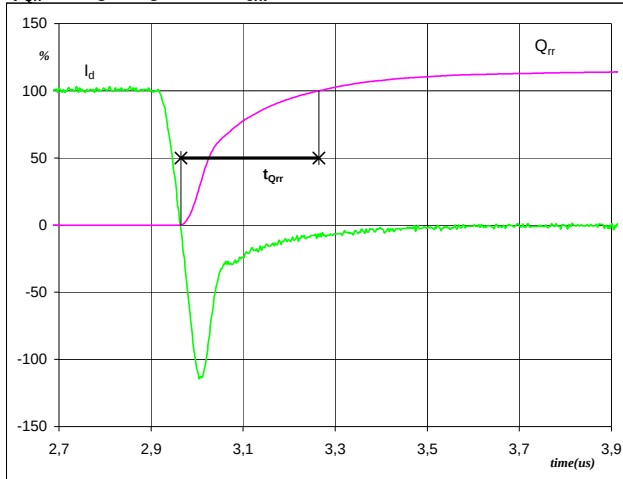
Turn-off Switching Waveforms & definition of t_{tr}


$V_d(100\%) = 300 \text{ V}$
 $I_d(100\%) = 99 \text{ A}$
 $I_{RRM}(100\%) = 113 \text{ A}$
 $t_{tr} = 0,25 \text{ }\mu\text{s}$

Switching Definitions Output Inverter

Figure 8 Output inverter FWD

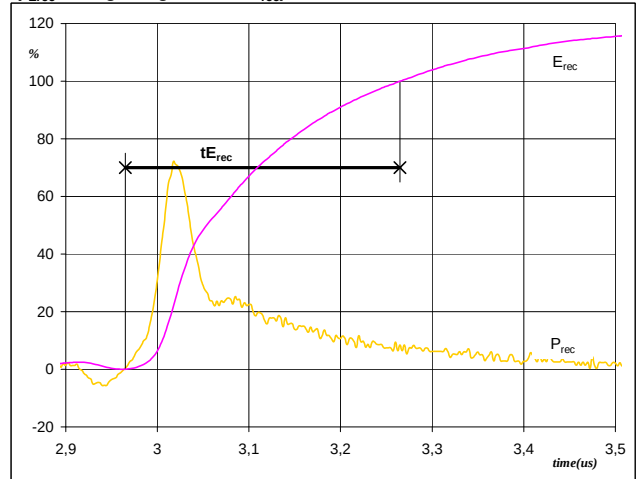
Turn-on Switching Waveforms & definition of t_{Qrr}
 (t_{Qrr} = integrating time for Q_{rr})



I_d (100%) = 99 A
 Q_{rr} (100%) = 10,50 μC
 t_{Qrr} = 0,30 μs

Figure 9 Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Erec}
 (t_{Erec} = integrating time for E_{rec})



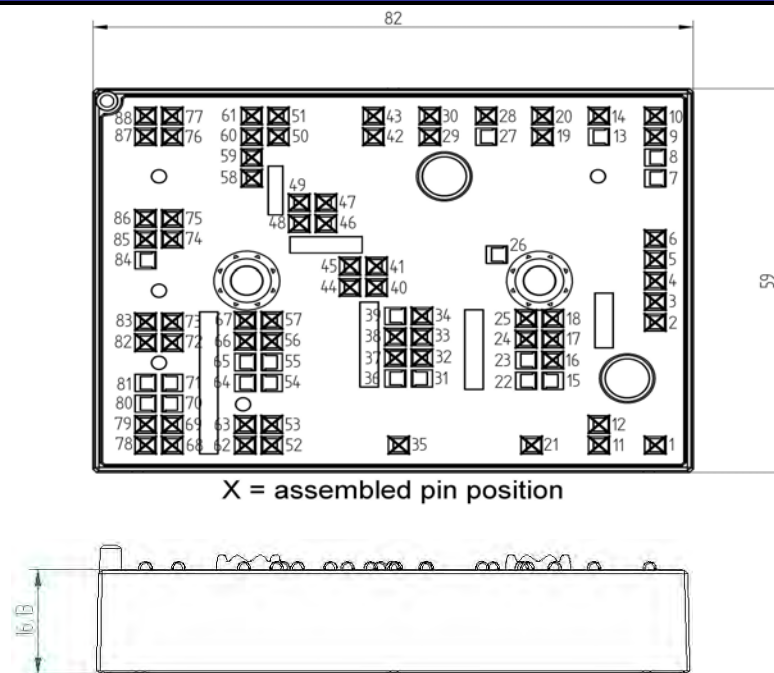
P_{rec} (100%) = 29,72 kW
 E_{rec} (100%) = 2,15 mJ
 t_{Erec} = 0,30 μs

Ordering Code and Marking - Outline - Pinout

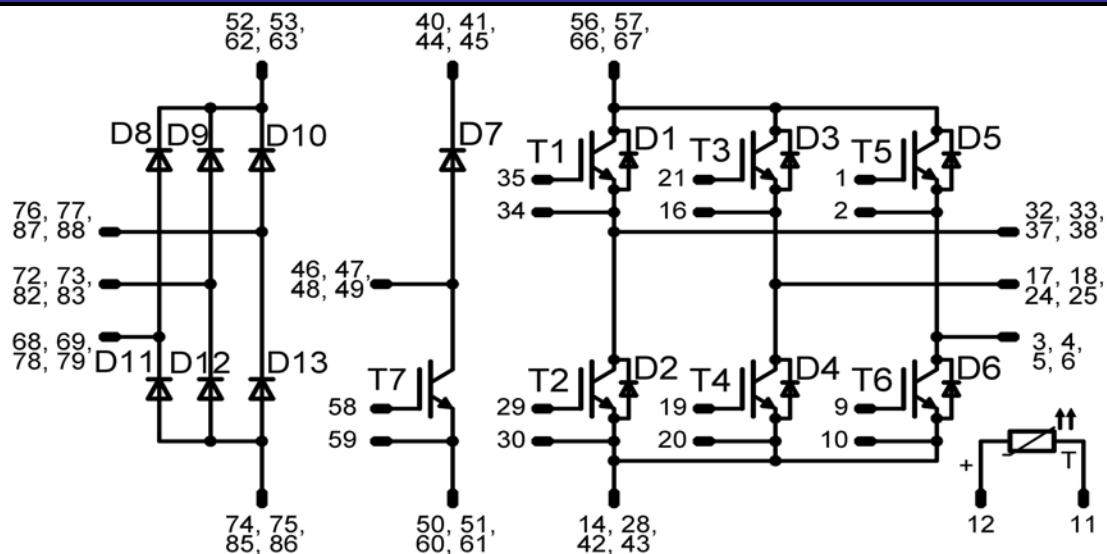
Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
with std lid (black V23990-K32-T-PM)	V23990-K243-A-/0A/-PM	K243A	K243A-/0A/
with std lid (black V23990-K32-T-PM) and P12	V23990-K243-A-/1A/-PM	K243A	K243A-/1A/
with thin lid (white V23990-K33-T-PM)	V23990-K243-A-/0B/-PM	K243A	K243A-/0B/
with thin lid (white V23990-K33-T-PM) and P12	V23990-K243-A-/1B/-PM	K243A	K243A-/1B/

Outline



Pinout



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